



# PHPT60610NY

60 V, 10 A NPN high power bipolar transistor

27 May 2015

Product data sheet

## 1. General description

NPN high power bipolar transistor in a SOT669 (LFPAK56) Surface-Mounted Device (SMD) power plastic package.

PNP complement: PHPT60610PY

## 2. Features and benefits

- High thermal power dissipation capability
- High temperature applications up to 175 °C
- Reduced Printed Circuit Board (PCB) requirements comparing to transistors in DPAK
- High energy efficiency due to less heat generation
- AEC-Q101 qualified.

## 3. Applications

- Power management
- Load switch
- Linear mode voltage regulator
- Backlighting applications
- Motor drive
- Relay replacement

## 4. Quick reference data

Table 1. Quick reference data

| Symbol      | Parameter                               | Conditions   | Min | Typ | Max | Unit       |
|-------------|---|--|-----|-----|-----|------------|
| $V_{CEO}$   | collector-emitter voltage               | open base  | -   | -   | 60  | V          |
| $I_C$       | collector current                       |  | -   | -   | 10  | A          |
| $I_{CM}$    | peak collector current                  | single pulse; $t_p \leq 1$ ms  | -   | -   | 20  | A          |
| $R_{CEsat}$ | collector-emitter saturation resistance | $I_C = 10$ A; $I_B = 1$ A; pulsed; $t_p \leq 300$ $\mu$ s;<br>$\delta \leq 0.02$ ; $T_{amb} = 25$ °C | -   | 25  | 36  | m $\Omega$ |

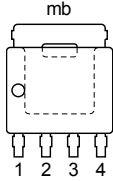
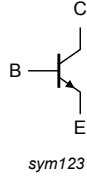


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## 5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline  | Graphic symbol  |
|-----|--------|-------------|---|---|
| 1   | E      | emitter     |  <p><b>LFPAK56; Power-SO8 (SOT669)</b></p> |  |
| 2   | E      | emitter     |   |   |
| 3   | E      | emitter     |   |   |
| 4   | B      | base        |   |   |
| mb  | C      | collector   |   |   |

## 6. Ordering information

Table 3. Ordering information

| Type number | Package            |  |         |
|-------------|--------------------|--|---------|
|             | Name               | Description  | Version |
| PHPT60610NY | LFPAK56; Power-SO8 | Plastic single-ended surface-mounted package (LFPAK56; Power-SO8); 4 leads | SOT669  |

## 7. Marking

Table 4. Marking codes

| Type number | Marking code |
|-------------|--------------|
| PHPT60610NY | 0610NAB      |

## 8. Limiting values

**Table 5. Limiting values**

*In accordance with the Absolute Maximum Rating System (IEC 60134).*

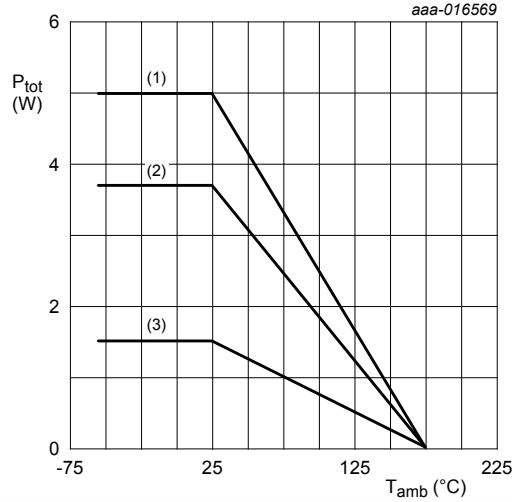
| Symbol    | Parameter                 | Conditions                    |     | Min | Max | Unit |
|-----------|---------------------------|-------------------------------|-----|-----|-----|------|
| $V_{CBO}$ | collector-base voltage    | open emitter                  |     | -   | 60  | V    |
| $V_{CEO}$ | collector-emitter voltage | open base                     |     | -   | 60  | V    |
| $V_{EBO}$ | emitter-base voltage      | open collector                |     | -   | 7   | V    |
| $I_C$     | collector current         |                               |     | -   | 10  | A    |
| $I_{CM}$  | peak collector current    | single pulse; $t_p \leq 1$ ms |     | -   | 20  | A    |
| $I_B$     | base current              |                               |     | -   | 1.5 | A    |
| $I_{BM}$  | peak base current         | single pulse; $t_p \leq 1$ ms |     | -   | 2   | A    |
| $P_{tot}$ | total power dissipation   | $T_{amb} \leq 25$ °C          | [1] | -   | 1.5 | W    |
|           |                           |                               | [2] | -   | 3.7 | W    |
|           |                           |                               | [3] | -   | 5   | W    |
|           |                           |                               | [4] | -   | 25  | W    |
| $T_j$     | junction temperature      |                               |     | -   | 175 | °C   |
| $T_{amb}$ | ambient temperature       |                               |     | -55 | 175 | °C   |
| $T_{stg}$ | storage temperature       |                               |     | -65 | 175 | °C   |

[1] Device mounted on an FR4 Printed-Circuit Board (PCB); single-sided copper; tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB; single-sided copper; tin-plated and mounting pad for collector 6 cm<sup>2</sup>.

[3] Device mounted on a ceramic PCB; Al<sub>2</sub>O<sub>3</sub>, standard footprint.

[4] Power dissipation from junction to mounting base.



- (1) Ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint
- (2) FR4 PCB, mounting pad for collector 6 cm<sup>2</sup>
- (3) FR4 PCB, standard footprint

Fig. 1. Power derating curves

## 9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol                | Parameter   | Conditions  |     | Min | Typ | Max | Unit |
|-----------------------|---|-------------|-----|-----|-----|-----|------|
| R <sub>th(j-a)</sub>  | thermal resistance from junction to ambient       | in free air | [1] | -   | -   | 100 | K/W  |
|                       |   |             | [2] | -   | -   | 41  | K/W  |
|                       |   |             | [3] | -   | -   | 30  | K/W  |
| R <sub>th(j-mb)</sub> | thermal resistance from junction to mounting base |             |     | -   | -   | 6   | K/W  |

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and mounting pad for collector 6 cm<sup>2</sup>.
- [3] Device mounted on a ceramic Printed-Circuit Board (PCB), Al<sub>2</sub>O<sub>3</sub>, standard footprint.

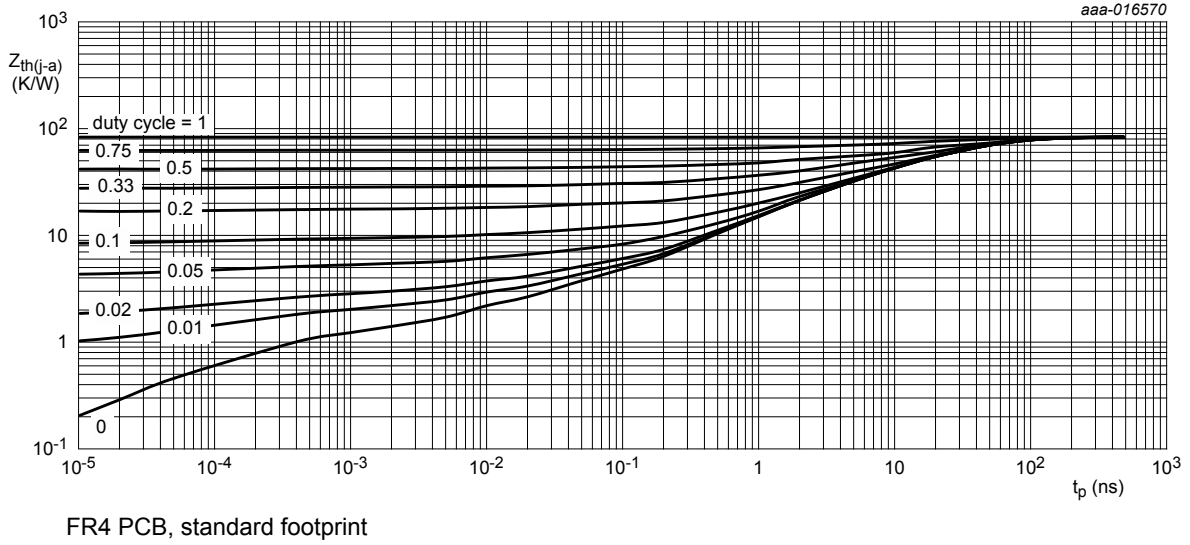


Fig. 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

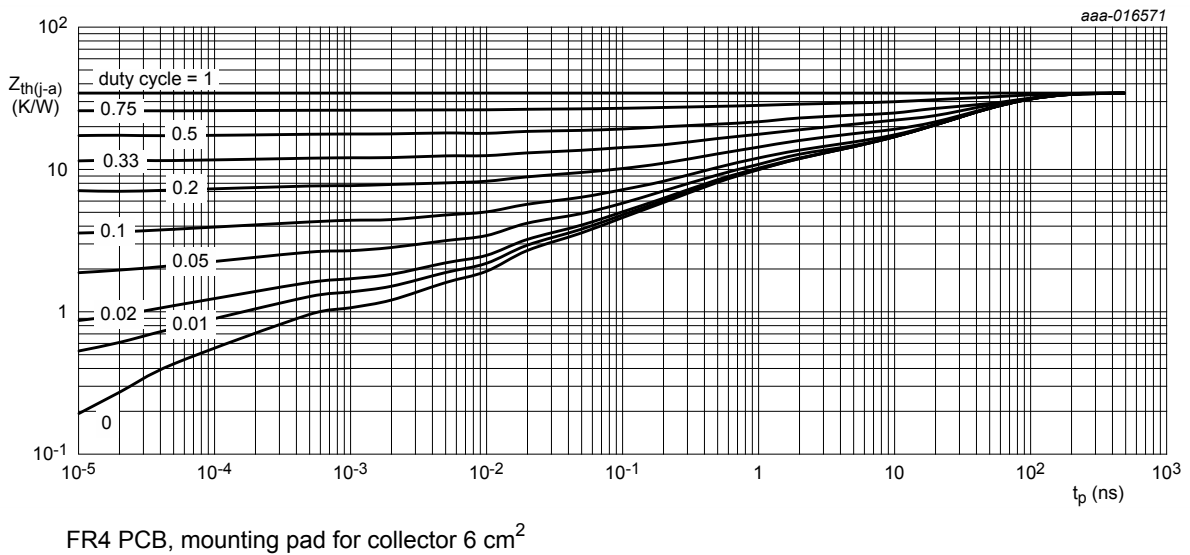


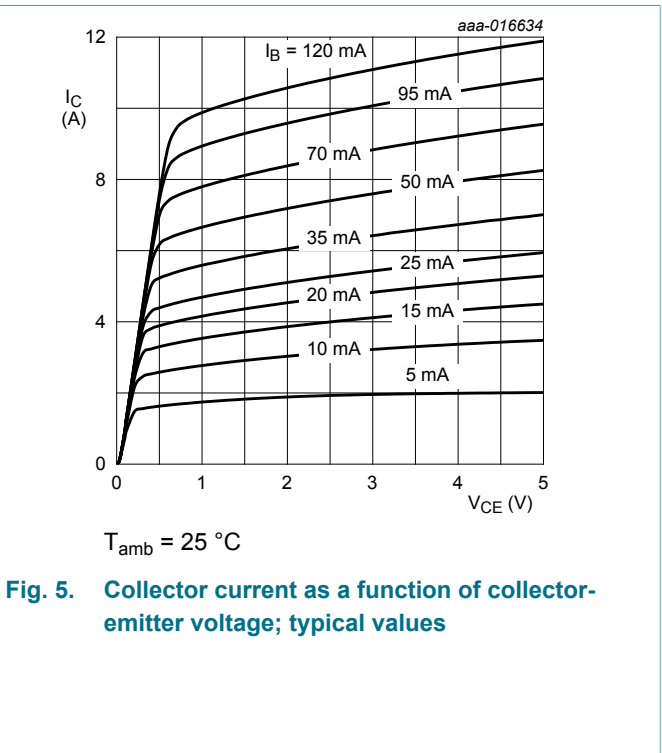
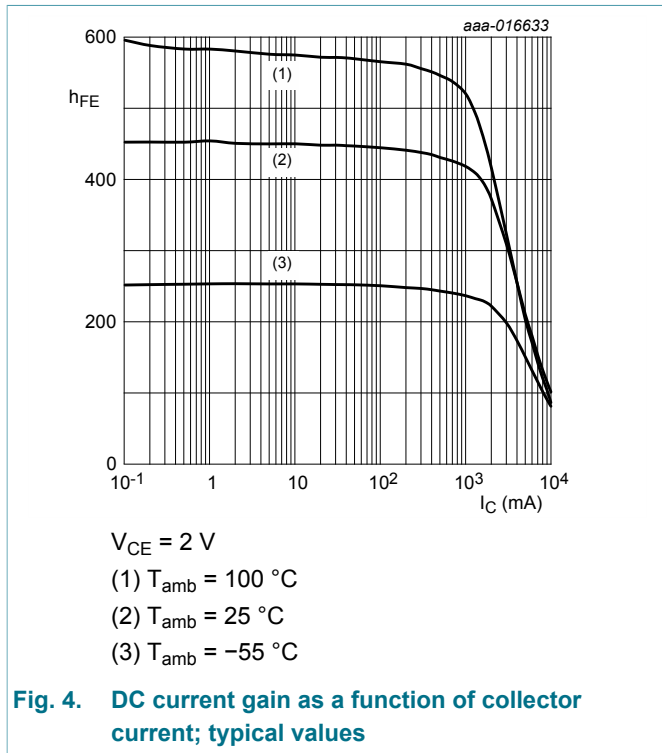
Fig. 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

## 10. Characteristics

Table 7. Characteristics

| Symbol             | Parameter                               | Conditions   | Min | Typ | Max  | Unit |
|--------------------|---|--|-----|-----|------|------|
| I <sub>CBO</sub>   | collector-base cut-off current          | V <sub>CB</sub> = 48 V; I <sub>E</sub> = 0 A; T <sub>amb</sub> = 25 °C   | -   | -   | 100  | nA   |
|                    |   | V <sub>CB</sub> = 48 V; I <sub>E</sub> = 0 A; T <sub>j</sub> = 150 °C  | -   | -   | 50   | μA   |
| I <sub>CES</sub>   | collector-emitter cut-off current       | V <sub>CE</sub> = 48 V; V <sub>BE</sub> = 0 V; T <sub>amb</sub> = 25 °C  | -   | -   | 100  | nA   |
| I <sub>EBO</sub>   | emitter-base cut-off current            | V <sub>EB</sub> = 7 V; I <sub>C</sub> = 0 A; T <sub>amb</sub> = 25 °C  | -   | -   | 100  | nA   |
| h <sub>FE</sub>    | DC current gain                         | V <sub>CE</sub> = 2 V; I <sub>C</sub> = 500 mA; T <sub>amb</sub> = 25 °C   | 240 | 410 | -    |      |
|                    |   | V <sub>CE</sub> = 2 V; I <sub>C</sub> = 1 A; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C                        | 210 | 400 | -    |      |
|                    |   | V <sub>CE</sub> = 2 V; I <sub>C</sub> = 5 A; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C                        | 100 | 200 | -    |      |
|                    |   | V <sub>CE</sub> = 2 V; I <sub>C</sub> = 10 A; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C; pulsed               | 50  | 100 | -    |      |
| V <sub>CEsat</sub> | collector-emitter saturation voltage    | I <sub>C</sub> = 1 A; I <sub>B</sub> = 50 mA; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C; pulsed               | -   | 30  | 40   | mV   |
|                    |   | I <sub>C</sub> = 5 A; I <sub>B</sub> = 500 mA; pulsed; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C              | -   | 115 | 160  | mV   |
|                    |   | I <sub>C</sub> = 10 A; I <sub>B</sub> = 1 A; pulsed; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C                | -   | 250 | 360  | mV   |
| R <sub>CEsat</sub> | collector-emitter saturation resistance | δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C  | -   | 25  | 36   | mΩ   |
| V <sub>BEsat</sub> | base-emitter saturation voltage         | I <sub>C</sub> = 1 A; I <sub>B</sub> = 50 mA; pulsed; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C               | -   | -   | 0.95 | V    |
|                    |   | I <sub>C</sub> = 5 A; I <sub>B</sub> = 500 mA; pulsed; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C              | -   | -   | 1.2  | V    |
|                    |   | I <sub>C</sub> = 10 A; I <sub>B</sub> = 1 A; pulsed; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C                | -   | -   | 1.4  | V    |
| V <sub>BEon</sub>  | base-emitter turn-on voltage            | V <sub>CE</sub> = 2 V; I <sub>C</sub> = 500 mA; T <sub>amb</sub> = 25 °C   | -   | -   | 0.8  | V    |
| t <sub>d</sub>     | delay time                              | V <sub>CC</sub> = 12.5 V; I <sub>C</sub> = 5 A; I <sub>Bon</sub> = 250 mA; I <sub>Boff</sub> = -250 mA; T <sub>amb</sub> = 25 °C | -   | 20  | -    | ns   |
| t <sub>r</sub>     | rise time                               |  | -   | 180 | -    | ns   |
| t <sub>on</sub>    | turn-on time                            |  | -   | 200 | -    | ns   |
| t <sub>s</sub>     | storage time                            |  | -   | 340 | -    | ns   |
| t <sub>f</sub>     | fall time                               |  | -   | 165 | -    | ns   |
| t <sub>off</sub>   | turn-off time                           |  | -   | 505 | -    | ns   |

| Symbol | Parameter             | Conditions   | Min | Typ | Max | Unit |
|--------|-----------------------|--|-----|-----|-----|------|
| $f_T$  | transition frequency  | $V_{CE} = 10\text{ V}; I_C = 500\text{ mA}; f = 100\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$              | -   | 140 | -   | MHz  |
| $C_c$  | collector capacitance | $V_{CB} = 10\text{ V}; I_E = 0\text{ A}; i_e = 0\text{ A}; f = 1\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | -   | 50  | -   | pF   |



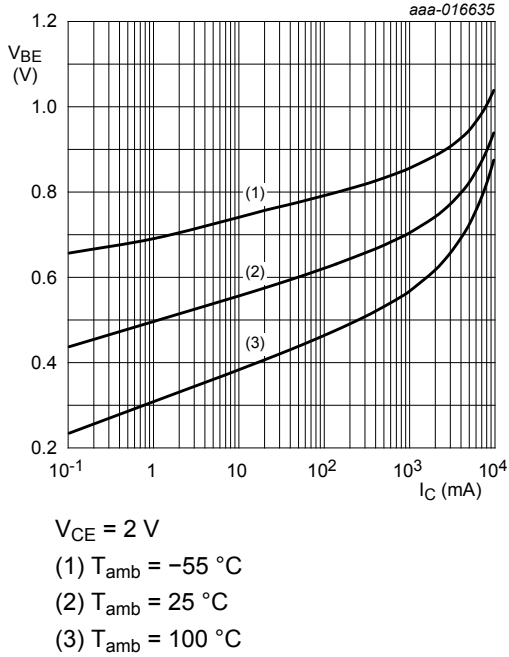


Fig. 6. Base-emitter voltage as a function of collector current; typical values

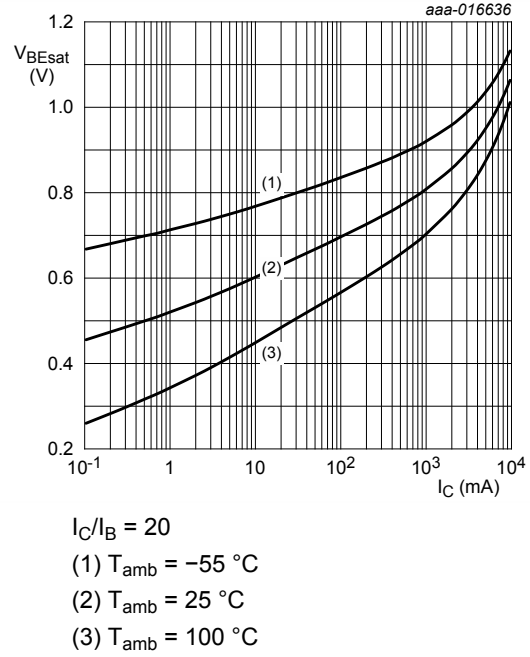


Fig. 7. Base-emitter saturation voltage as a function of collector current; typical values

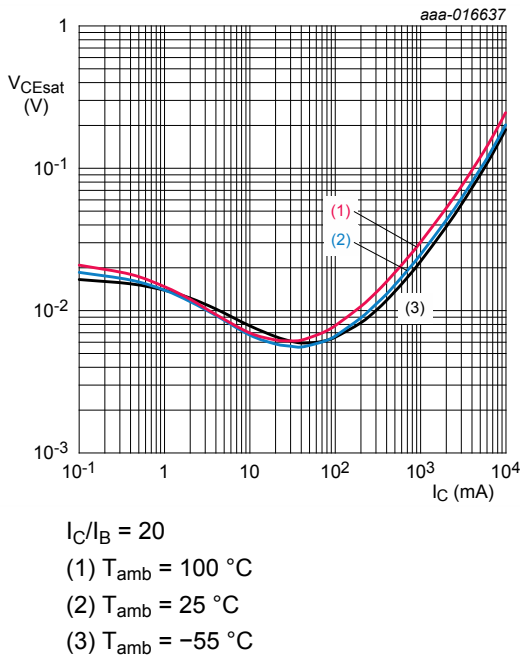


Fig. 8. Collector-emitter saturation voltage as a function of collector current; typical values

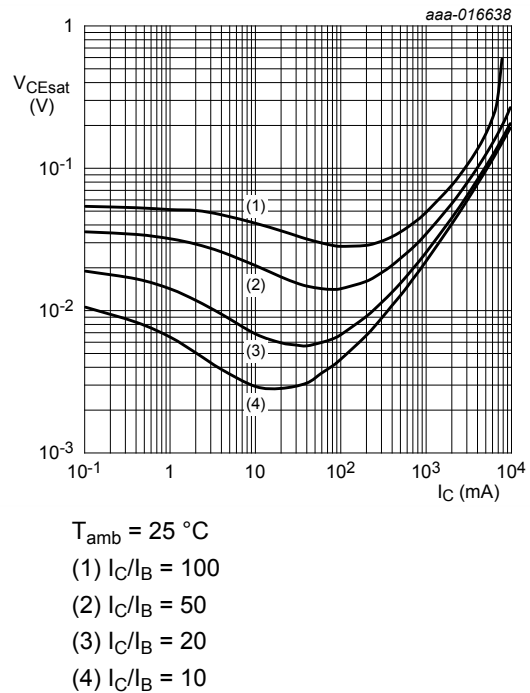
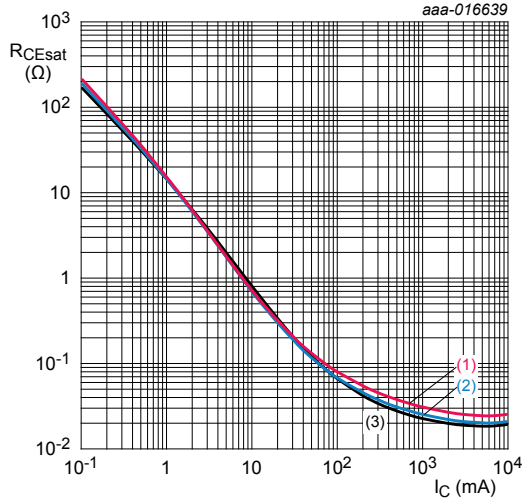


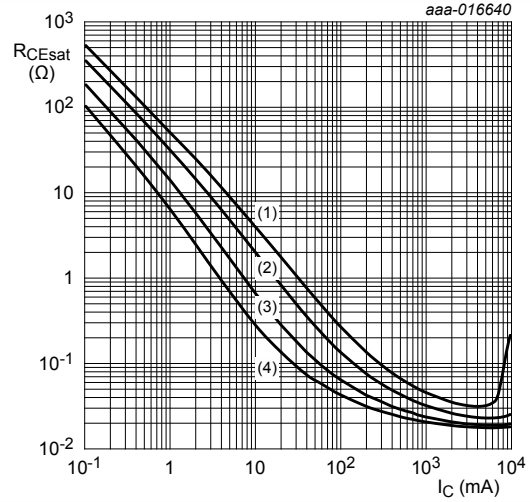
Fig. 9. Collector-emitter saturation voltage as a function of collector current; typical values





- $I_C/I_B = 20$
- (1)  $T_{amb} = 100\text{ °C}$
  - (2)  $T_{amb} = 25\text{ °C}$
  - (3)  $T_{amb} = -55\text{ °C}$

Fig. 10. Collector-emitter saturation resistance as a function of collector current; typical values



- $T_{amb} = 25\text{ °C}$
- (1)  $I_C/I_B = 100$
  - (2)  $I_C/I_B = 50$
  - (3)  $I_C/I_B = 20$
  - (4)  $I_C/I_B = 10$

Fig. 11. Collector-emitter saturation resistance as a function of collector current; typical values

### 11. Test information

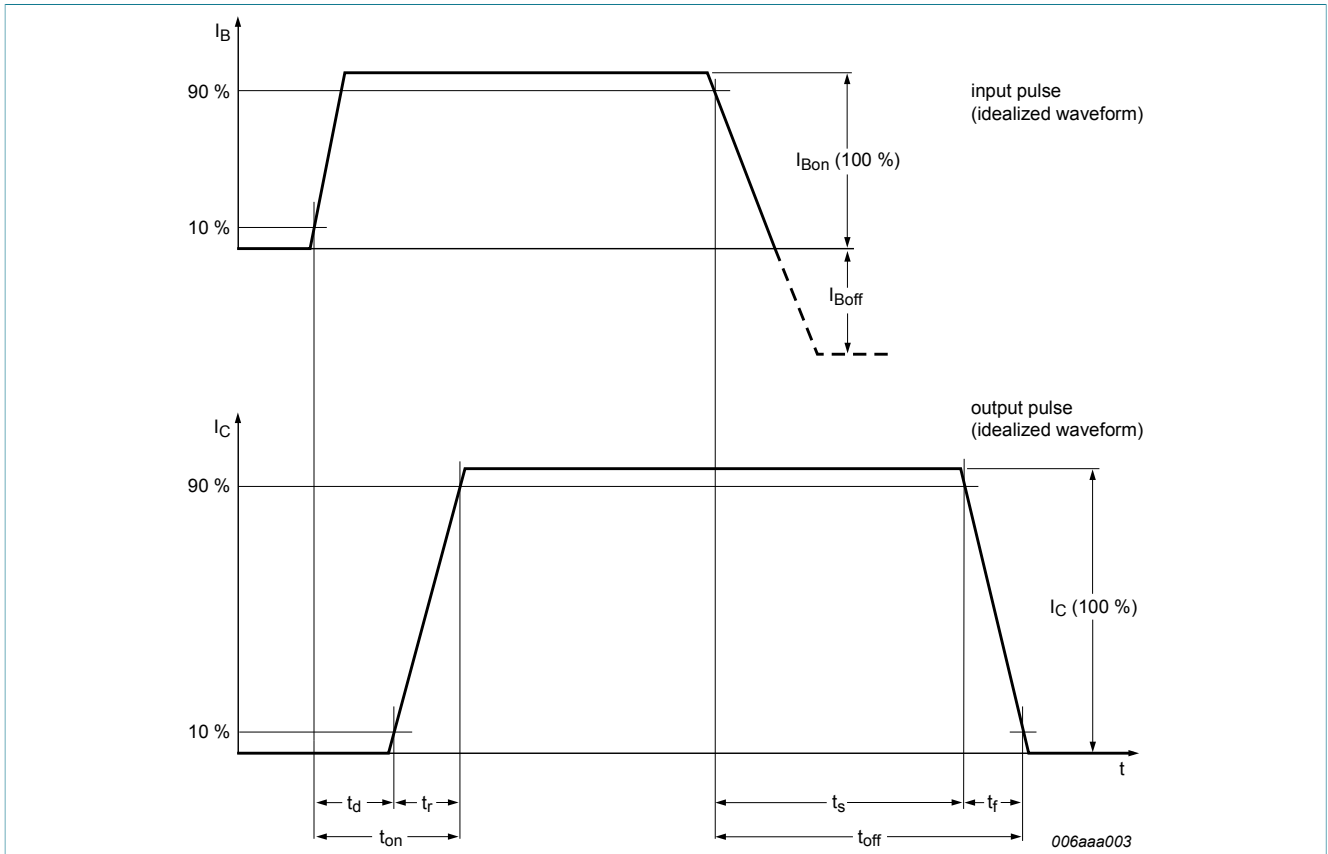


Fig. 12. BISS transistor switching time definition

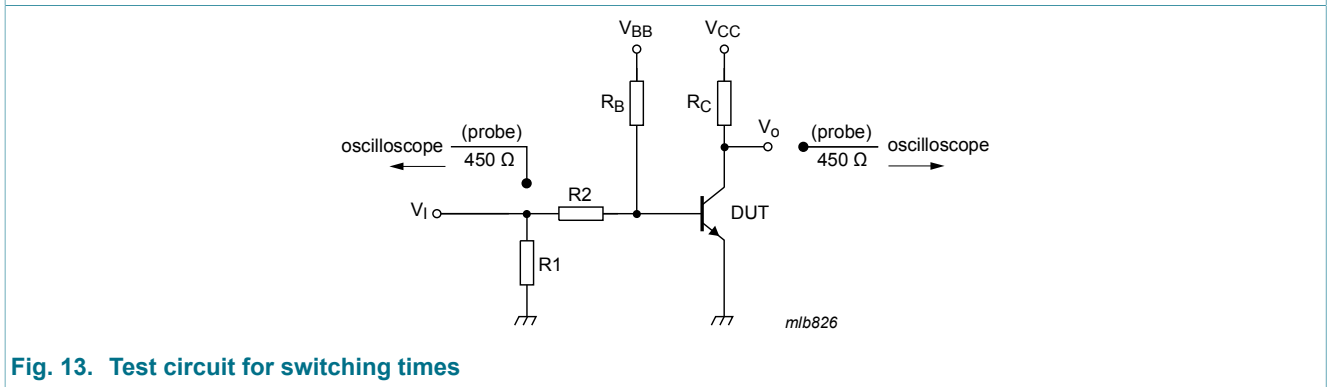


Fig. 13. Test circuit for switching times

#### 11.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q101 - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

## 12. Package outline

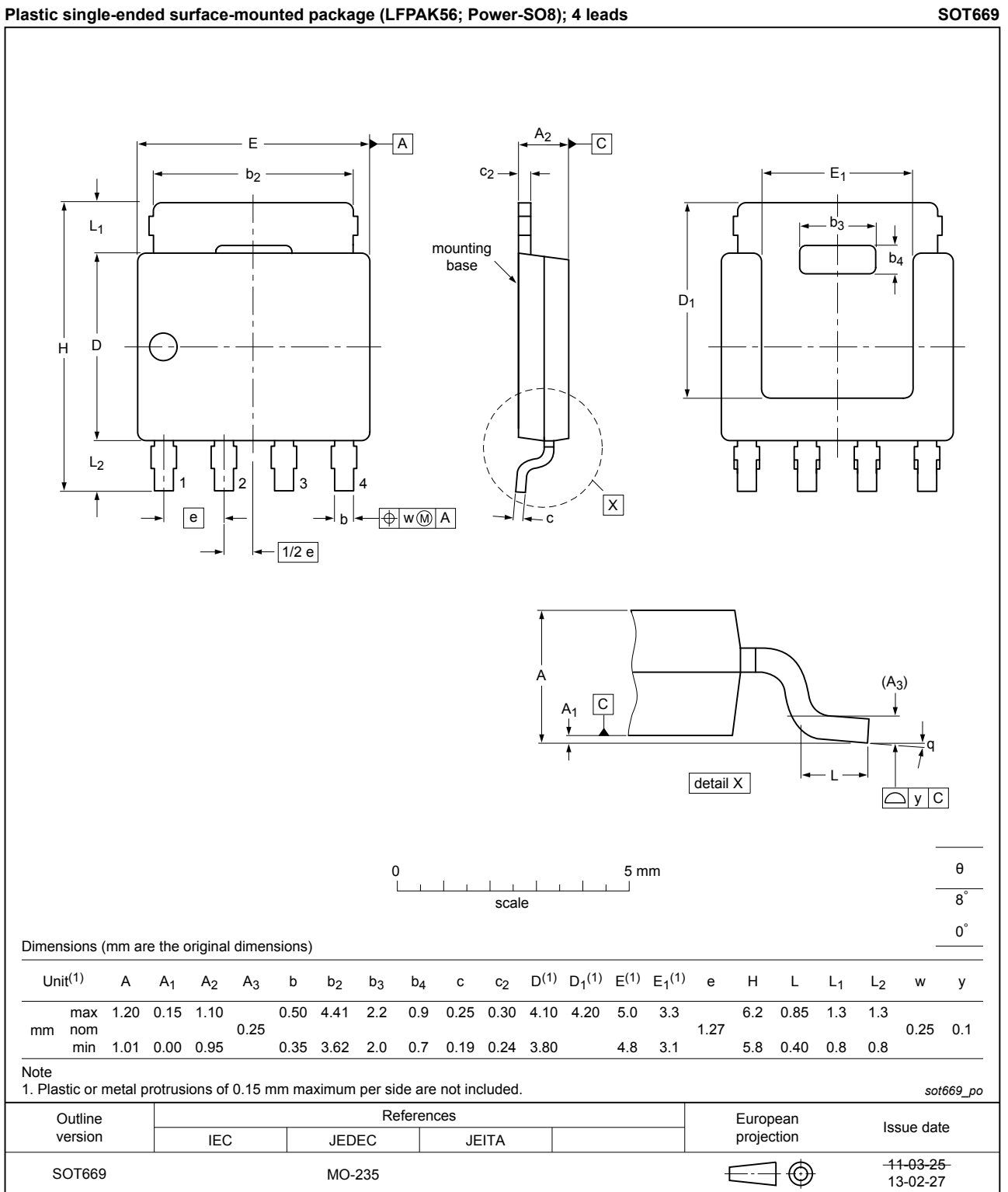


Fig. 14. Package outline LFAK56; Power-SO8 (SOT669)

### 13. Soldering

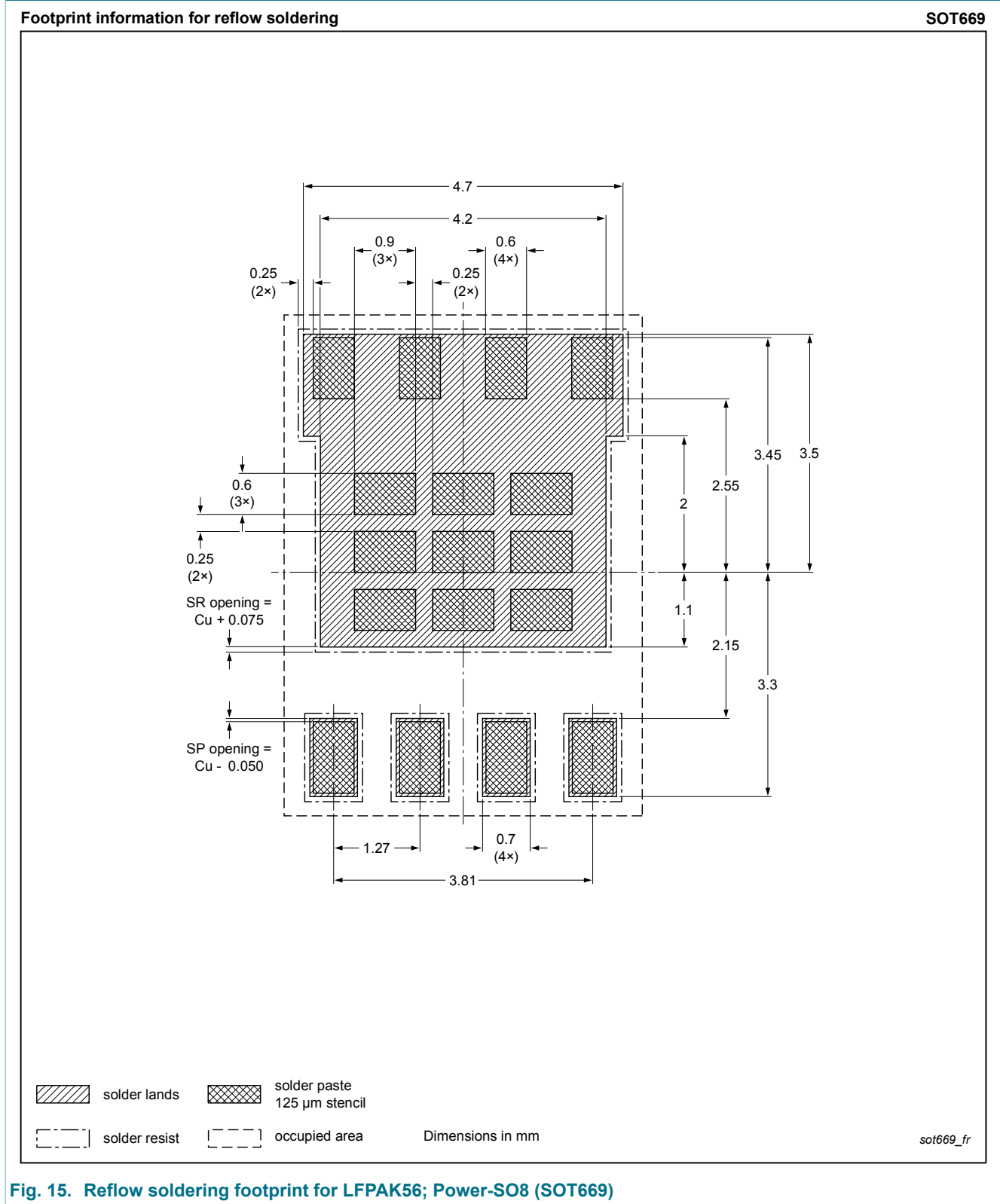


Fig. 15. Reflow soldering footprint for LFPAK56; Power-SO8 (SOT669)

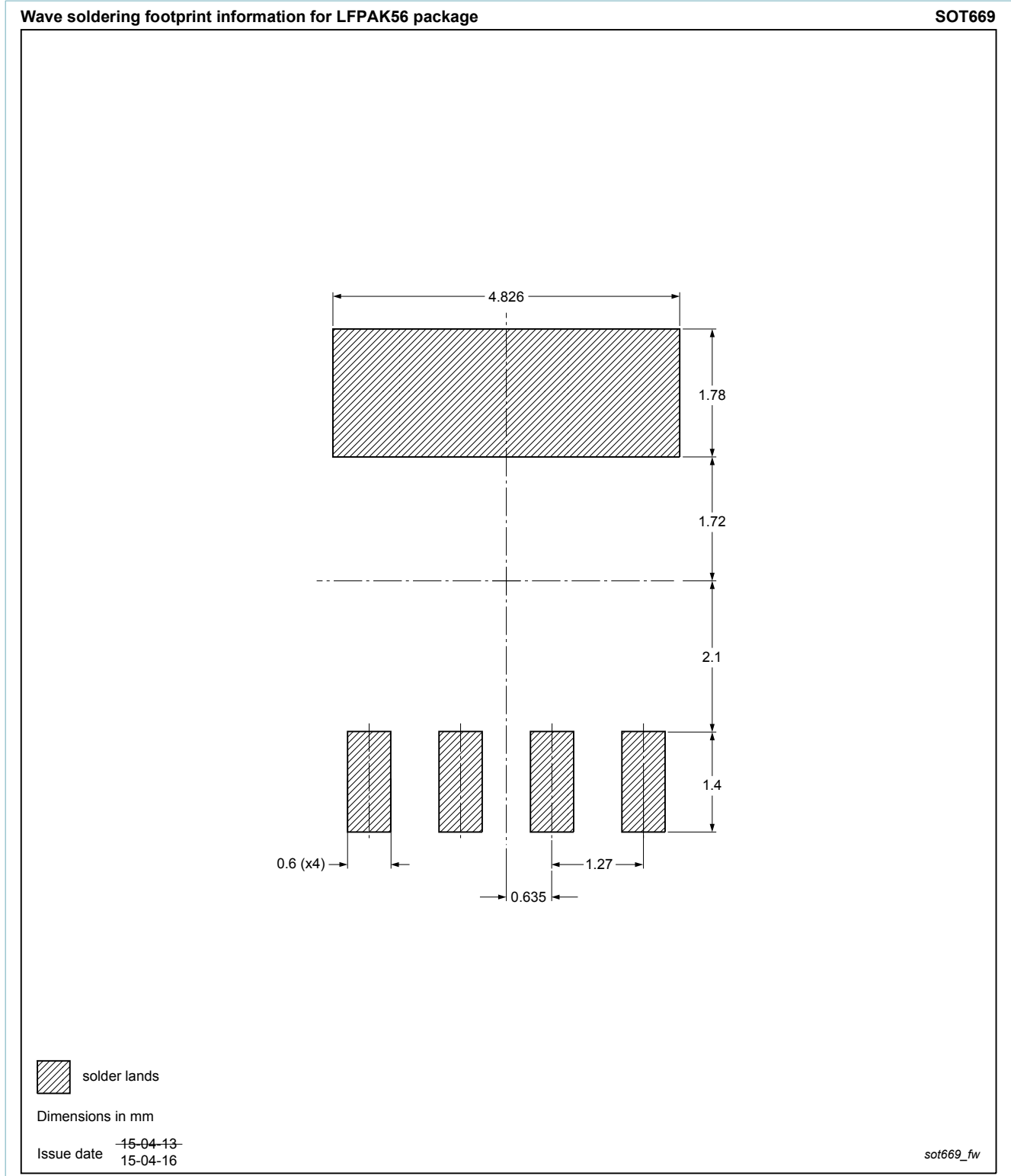


Fig. 16. Wave soldering footprint for LFPAK56; Power-SO8 (SOT669)

## 14. Revision history

Table 8. Revision history

| Data sheet ID   | Release date | Data sheet status  | Change notice | Supersedes |
|-----------------|--------------|--------------------|---------------|------------|
| PHPT60610NY v.1 | 20150527     | Product data sheet | -             | -          |

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| Document status [1][2]         | Product status [3] | Definition  |
|--------------------------------|--------------------|---|
| Objective [short] data sheet   | Development        | This document contains data from the objective specification for product development. |
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## 16. Contents

|      |                               |    |
|------|-------------------------------|----|
| 1    | General description .....     | 1  |
| 2    | Features and benefits .....   | 1  |
| 3    | Applications .....            | 1  |
| 4    | Quick reference data .....    | 1  |
| 5    | Pinning information .....     | 2  |
| 6    | Ordering information .....    | 2  |
| 7    | Marking .....                 | 2  |
| 8    | Limiting values .....         | 3  |
| 9    | Thermal characteristics ..... | 4  |
| 10   | Characteristics .....         | 6  |
| 11   | Test information .....        | 10 |
| 11.1 | Quality information .....     | 10 |
| 12   | Package outline .....         | 11 |
| 13   | Soldering .....               | 12 |
| 14   | Revision history .....        | 14 |
| 15   | Legal information .....       | 15 |
| 15.1 | Data sheet status .....       | 15 |
| 15.2 | Definitions .....             | 15 |
| 15.3 | Disclaimers .....             | 15 |
| 15.4 | Trademarks .....              | 16 |

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